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## ED STATES PATENT / NO TRADEMARK OFFICE

Applicant : Peter de Groot et al.

Ait Unit

: Unknown

Serial No.: 09/769,859

Examiner: Unknown

Filed

: **Ja**nuary 25, 2001

Title

: OPTICAL SYSTEMS FOR MEASURENCE FORM AND GEOMETRIC

DIMENSIONS OF PRECISION ENGINEERED PARTS

Commissioner for Patents Washington, D.C. 20231

## INFORMATION DISCLOSULE STATEMENT

Applicant submits the references listed on the characted form PTO-1449, copies of which are enclosed. A copy of a communication from a foreign patent office in a counterpart application is also enclosed.

This statement is being filed before the receipt of a first Office action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted.

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Sheet	1	of	1

Substitute Form PTO-1449	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 09712-057001	Application No. 09/769,859	
mormation Disclosure Statement by Applicant		Applicant Peter de Groot et al.		
(Use several sh	eets if necessary)	Filing Date January 25, 2001	Group Art Unit	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,363,196	11/08/94	Cameron			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	ΑI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or				lation
Initial_	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL	<b>EP 0 352 5</b> 35	01/31/90	Europe				
	AM	EP 0 179 935	05/07/86	Europe				
	AN	WO 5 3/02938	01/21/99	WIPO				
	AO							
-	AP							

(	Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner Initial	Desig. ID	Document			
	AQ	Copy of International Search Report, dated October 16, 2001			
	AR				
	AS	·			
	AT				

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation of n	of in conformance and not considered. Include copy of this form with

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